Search Notes

Application No. 09/841,875	**Applicant(s)** CHO ET AL.
Examiner Daniel Pan	**Art Unit** 2183

SEARCHED

Class	Subclass	Date	Examiner
712	202 227 248	7/30/2004	DP
717	124 129	7/30/2004	DP
714	23 35	7/30/2004	DP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
USPAT PGP FULL TEXT JOPABS EPOABS DERWENT IBM TDB IEEE ELECTRONIC LIB debug with stack and reset mode SEARCHED	7/30/2004	DP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

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